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Contents of Vol. 140

Part 1

Low Temperature Biological Microscopy and Analysis

Introduction 1
ERWIN MAYER. Vitrification of pure liquid water 3
W. B. BALD. The relative merits of various cooling methods 17
R. A. STEINBRECHT. Recrystallization and ice-crystal growth in a biological specimen, as shown by a simple freeze substitution method 41
KEITH P. RYAN and DAVID H. PURSE. Plunge-cooling of tissue blocks: determinants of cooling rates 47
E. CARLEMALM, W. VILLIGER, J. A. HOBOT, J.-D. ACETARIN and E. KELLENBERGER. Low temperature embedding with Lowicryl resins: two new formulations and some applications 55
KARL ZIEROLD. Contrast of biological cryosections in scanning transmission electron microscopy 65
J. LEPAULT. Cryo-electron microscopy of helical particles TMV and T4 polyheads 73
R. LYON, J. APPLETON, K. J. SWINDIN, J. J. ABBOT and J. CHESTERS. An inexpensive device for freeze drying and plastic embedding tissues at low temperatures 81
J. B. FINEAN, A. HUTCHINSON and D. MILLS. Phase separation in frozen erythrocyte membrane preparations 93
A. T. MARSHALL and R. J. CONDRON. Normalization of light element X-ray intensities for surface topography effects in frozen-hydrated biological bulk samples 99
A. T. MARSHALL and R. J. CONDRON. X-ray microanalytical resolution in frozen-hydrated biological bulk samples 109
J. BOONSTRA, N. VAN BELZEN, P. VAN MAVRIK, W. J. HAGE, F. J. BLOK, F. A. C. WIEGANT and A. J. VERKLEIJ. Immunocytological demonstration of cytoplasmic and cell-surface EGF receptors in A431 cells using cryo-ultramicrotomy, surface replication, freeze-etching and label fracture 119

Book Reviews 131

Rapid Publications
R. J. ROSSER, R. FEDER, A. NG and P. CELLIERS. Single shot soft X-ray microscopy using plasmas generated by a laboratory sized Nd-glass laser RP1
NORBERT ROOS and A. JOHN MORGAN. Aminoplastic standard for electron probe X-ray microanalysis (EPXMA) of ultrathin frozen-dried cryosections RP3

Part 2

The Microscopy of Ceramics

Introduction 135
E. W. Roberts and P. C. Robinson. Light microscopy of ceramics 137
J. T. Czernuszka and T. F. Page. The importance of microscopy in studying the wear behaviour of ceramic surfaces 159
E. P. Butler. Transmission electron microscopy of zirconia ceramics 171
J. G. P. Binner, R. Stevens and S. R. Tan. Toughening of hot pressed beta-alumina using zirconia additions prepared from zirconate, tartrate and carbonate precursor materials 183
S. B. Newcomb, C. B. Boothroyd and W. M. Stobbs. Specimen preparation methods for the examination of surfaces and interfaces in the transmission electron microscope 195
S. B. Newcomb and W. M. Stobbs. The characterization of interfacial structures in the oxidation of Fe and FeNiCr alloys by edge-on transmission electron microscopy 209
A. T. Chadwick and R. I. Taylor. Electron microscopy of oxide scales modified to resist high-temperature oxidation 221
J. F. Watts. Analysis of ceramic materials by electron spectroscopy 243
A. J. Bourdillon and G. P. Tebby. EXELFS of alumina, *ab initio* calculations and the measurement of charge transfer 261

Rapid Publication
W. Coene and D. van Dyck. Real space method versus fast-Fourier-transform multi-slice method: comments and discussion RP5

Part 3

Editorial 281

Low Voltage SEM

Introduction 282
David C. Joy. Resolution in low voltage scanning electron microscopy 283
D. W. Tuggle, J. Z. Li and L. W. Swanson. Point cathodes for use in virtual source electron optics 293
J. Orloff. Thermal field emission for low voltage scanning electron microscopy 303
H. Todokoro, S. Yoneda, K. Yamaguchi, S. Fukuhara and T. Komoda. Stroboscopic testing of LSIs with low voltage scanning electron microscope 313
P. E. Russell and J. F. Mancuso. Microchannel plate detector for low voltage scanning electron microscopes 323
E. Menzel and R. Buchanan. Some recent developments in low voltage E-beam testing of ICs 331

Philip Gash and Fritz Lüty. Normarski differential interference microscopy study of the ferroelastic domains in NaCN, RbCN and KCN 351
Karl-Heinz Hanisch, Dieter König and Dietrich Stoyan. The pair correlation function for point and fibre systems and its stereological determination by planar sections 361
E. W. Hansen, R. D. Allen, J. W. Strohbehn, M. A. Chaffee, D. L. Farrington, W. F. Murray, T. A. Pillsbury and M. F. Riley. Laser scanning phase modulation microscope 371
J. A. Treverton and M. P. Amor. The effect of subsurface topography on secondary electron images from chromate pretreated aluminium surfaces 383
M. S. Foster, J. C. Campuzano, R. F. Willis and J. C. Dupuy. A mirror electron microscope for surface analysis 395